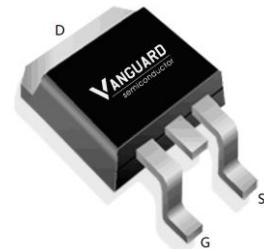


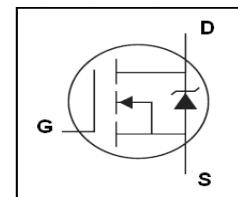
Features

- N-Channel, 10V Logic Level Control
- Enhancement mode
- Low on-resistance $R_{DS(on)}$ @ $V_{GS}=10V$
- Fast Switching
- 100% Avalanche Test
- Pb-free lead plating; RoHS compliant

V_{DS}	70	V
$R_{DS(on),TYP}$ @ $V_{GS}=10 V$	7.3	$m\Omega$
I_D	83	A

TO-263

Halogen-Free

Part ID	Package Type	Marking	Tape and reel information
VSM008N07HS	TO-263	008N07H	800pcs/Reel



Maximum ratings, at $T_j=25^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	70	V
I_s	Diode continuous forward current	$T_c=25^{\circ}\text{C}$	A
I_D	Continuous drain current@ $V_{GS}=10V$	$T_c=25^{\circ}\text{C}$	A
		$T_c=100^{\circ}\text{C}$	A
I_{DM}	Pulse drain current tested ①	$T_c=25^{\circ}\text{C}$	A
EAS	Avalanche energy, single pulsed ②	196	mJ
P_D	Maximum power dissipation	$T_c=25^{\circ}\text{C}$	W
V_{GS}	Gate-Source voltage	± 25	V
$T_{STG} T_J$	Storage and operating temperature range	-55 to 175	$^{\circ}\text{C}$

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	1.25	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance Junction-Ambient	62.5	$^{\circ}\text{C}/\text{W}$

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	70	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current($T_c=25^\circ\text{C}$)	$V_{\text{DS}}=70\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
	Zero Gate Voltage Drain Current($T_c=125^\circ\text{C}$)	$V_{\text{DS}}=70\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 25\text{V}, V_{\text{DS}}=0\text{V}$	--	--	± 100	nA
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2	2.9	4	V
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance ③	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=40\text{A}$	--	7.3	9	$\text{m}\Omega$
Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
C_{iss}	Input Capacitance	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	--	3330	--	pF
C_{oss}	Output Capacitance		--	275	--	pF
C_{rss}	Reverse Transfer Capacitance		--	230	--	pF
R_g	Gate Resistance	$f=1\text{MHz}$	--	1.7	--	Ω
Q_g	Total Gate Charge	$V_{\text{DS}}=35\text{V}, I_{\text{D}}=40\text{A}, V_{\text{GS}}=10\text{V}$	--	26	--	nC
Q_{gs}	Gate-Source Charge		--	7.8	--	nC
Q_{gd}	Gate-Drain Charge		--	11	--	nC
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=35\text{V}, I_{\text{D}}=40\text{A}, R_{\text{G}}=3\Omega, V_{\text{GS}}=10\text{V}$	--	11	--	nS
t_r	Turn-on Rise Time		--	5.8	--	nS
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	49	--	nS
t_f	Turn-Off Fall Time		--	6.9	--	nS
Source- Drain Diode Characteristics@ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
V_{SD}	Forward on voltage	$I_{\text{SD}}=40\text{A}, V_{\text{GS}}=0\text{V}$	--	0.85	1.2	V
t_{rr}	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{sd}}=40\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=500\text{A}/\mu\text{s}$	--	12	--	nS
Q_{rr}	Reverse Recovery Charge		--	17	--	nC

NOTE:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by $T_{J\text{max}}$, starting $T_J = 25^\circ\text{C}$, $L = 0.5\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 28\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value
- ③ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

Typical Characteristics

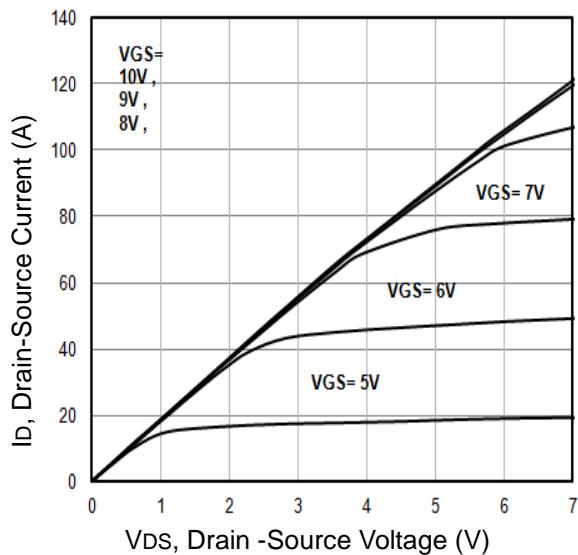


Fig1. Typical Output Characteristics

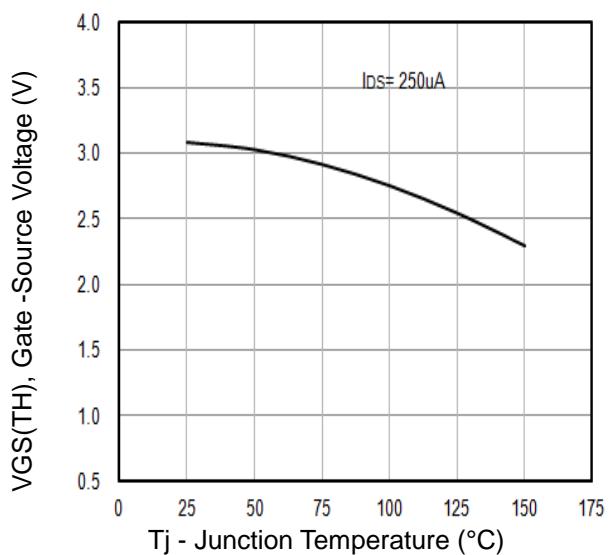


Fig2. $V_{GS(TH)}$ Gate-Source Voltage Vs. T_j

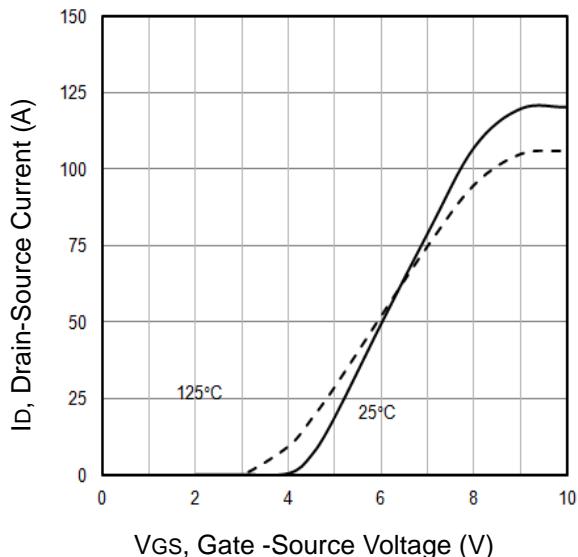


Fig3. Typical Transfer Characteristics

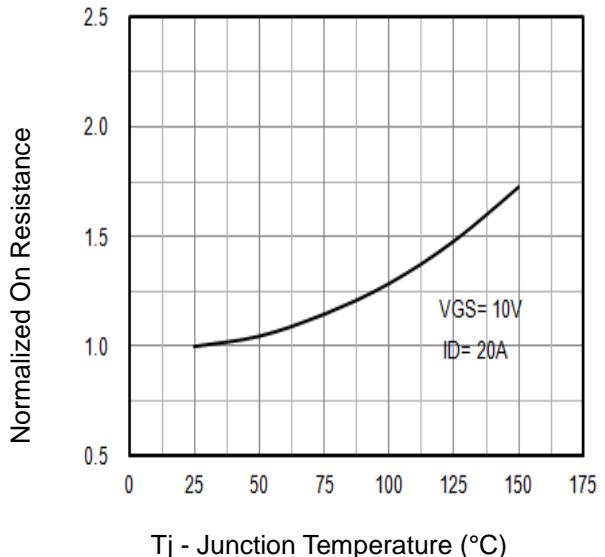


Fig4. Normalized On-Resistance Vs. T_j

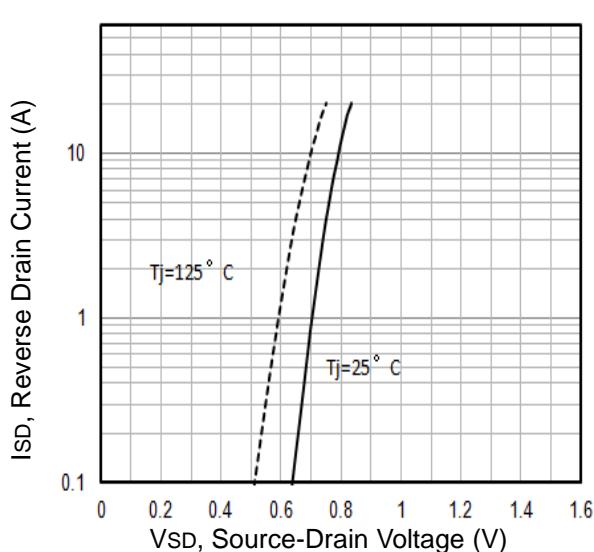


Fig5. Typical Source-Drain Diode Forward Voltage

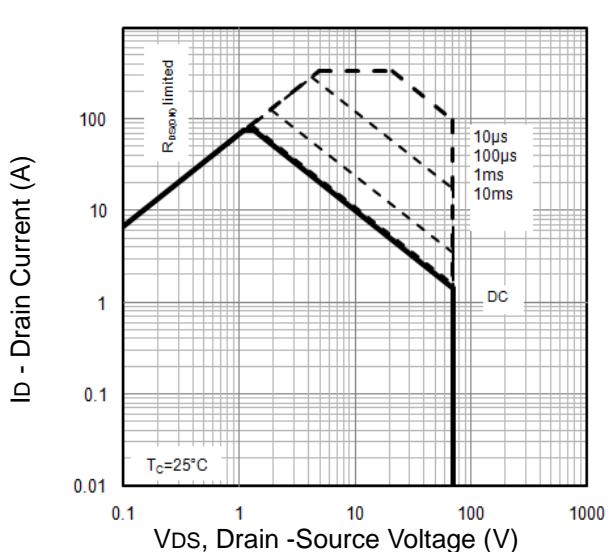


Fig6. Maximum Safe Operating Area

Typical Characteristics

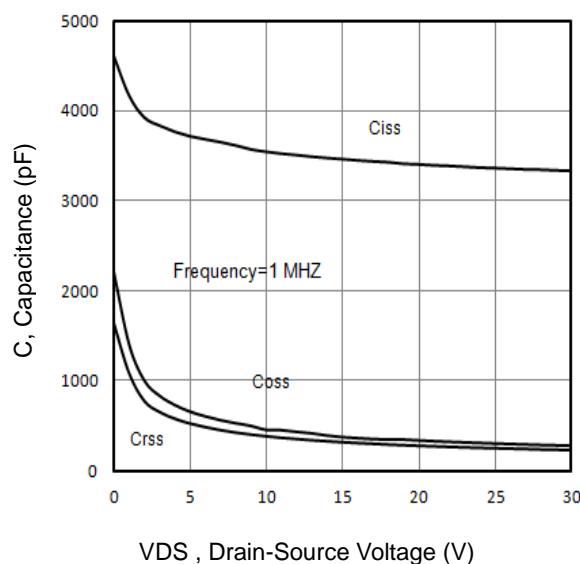


Fig7. Typical Capacitance Vs.Drain-Source Voltage

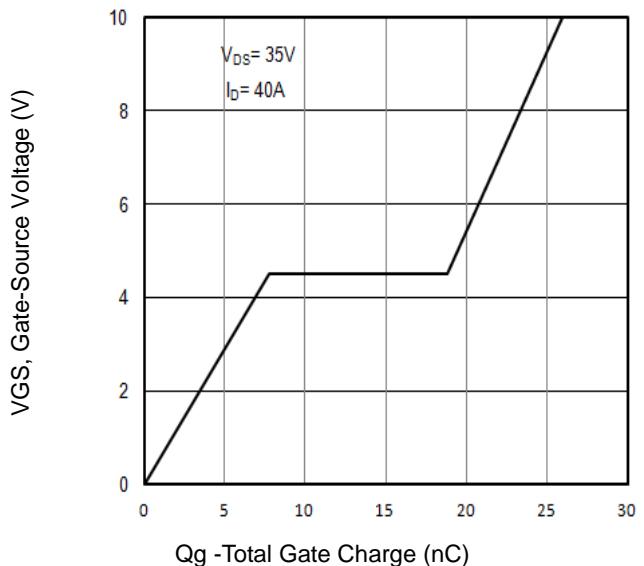


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

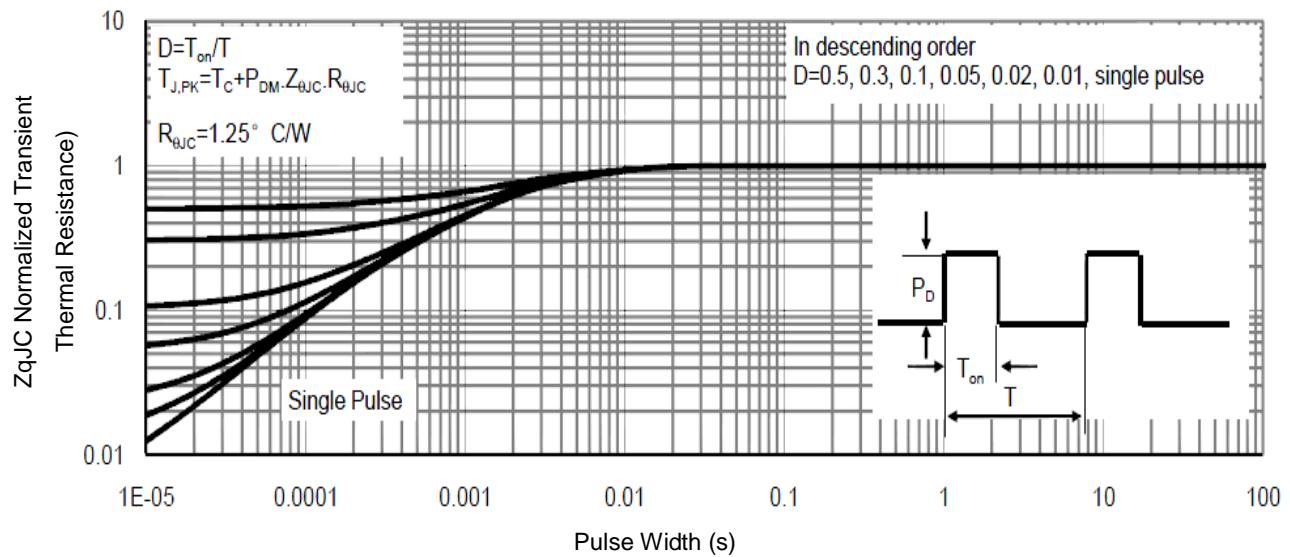


Fig9 . Normalized Maximum Transient Thermal Impedance

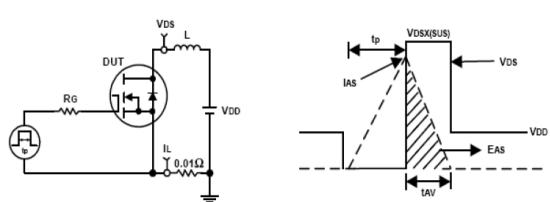


Fig11. Unclamped Inductive Test Circuit and waveforms

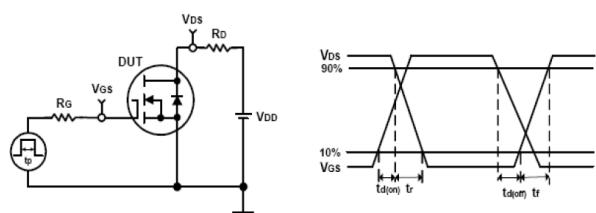
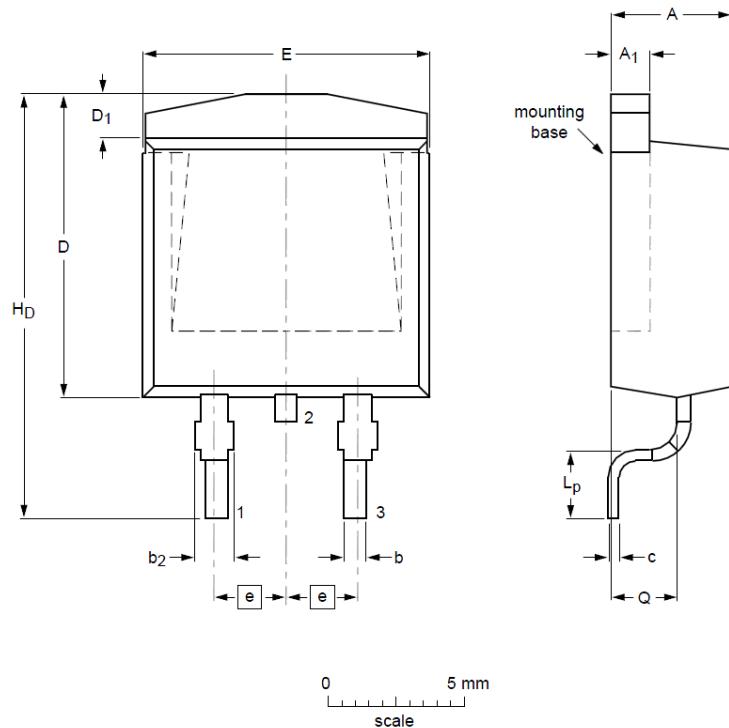


Fig12. Switching Time Test Circuit and waveforms

TO-263 Package Outline Data



DIMENSIONS (unit : mm)

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	4.40	4.55	4.70	A ₁	1.25	1.30	1.40
b	0.60	0.76	0.85	b ₂	1.05	1.30	1.45
c	0.35	0.45	0.60	D	9.80	10.20	10.50
D ₁	1.20	1.51	1.60	E	9.70	10.10	10.30
e	--	2.54	--	H _D	14.80	15.45	15.80
L _P	2.10	2.40	2.90	Q	2.20	2.50	2.60

Customer Service

Sales and Service:

sales@vgsemi.com

Vanguard Semiconductor CO., LTD

TEL: (86-755) -26902410

FAX: (86-755) -26907027

WEB: www.vgsemi.com